Antenna Gain and Scattering Measurement Using Reflective Three-Antenna Method

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I. INTRODUCTION

Three-antenna method [1] is a technique to measure the antenna gain without using a reference antenna. Since it operates in a transmission-type arrangement, a long return cable is required. Several methods were then developed to eliminate the return cable by using the radar cross section (RCS) measurement method. The advantages of this method are described in [2]-[6]. In [7], a measurement method based on RCS measurement concept and antenna scattering matrix is developed. It can not only measure the antenna gain, but also derive the structural scattering characteristics and antenna input impedance from the measurement. However, it requires a complicated polarimetric calibration procedure for the measurement system.

In this paper, a novel method is proposed to combine the concepts of three-antenna method and RCS measurement method to measure the antenna gain and its structural scattering characteristics without involving the reference antenna or polarimetric calibration. In this method, the measurement arrangement including the transmitting and receiving antennas is considered as a two-port network with reference planes at the input port for each antenna as shown in Fig.1. By connecting three different known terminators at the receiving antenna port and measure the reflection coefficients at the transmitting antenna port, the scattering parameters of this two-port network can be derived. They are shown to be related to the product of two antennas' gain. Therefore one can follow the three-antenna method to find the gain of each antenna. In addition, the structural scattering characteristics of each antenna can be solved.

II. FORMULATION

As shown in Fig.1, antenna *i* and antenna *j* and the free space between them can be considered as a two-port network with its reference planes at the terminating ports *i* and *j*. The two-port scattering matrix $[S^T]$ of this two-port network is then related to the scattering matrices $[S^i]$ and $[S^j]$ of each antenna. In the following section, the formulation to derive the two-port scattering matrix $[S^T]$ using the reflection measurement is given first. The relation between the measured two-port scattering parameters $[S^T]$ and two antenna scattering matrices is given in Sec. II.B. The concept of

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three-antenna method is then adopted to measure the antenna gain and its structural scattering from the antenna scattering matrix representation.

A. Two-port scattering parameter measurement using reflection measurement As a terminator with reflection coefficient of Γ_a is connected at the port 2 of a re-

ciprocal two-port network, $S_{11}^{(a)}$ of this terminated one-port network is related to S_{ij}

of the original two-port network is given as

$$S_{11}^{(a)} = S_{11} + \frac{S_{12}^2 \Gamma_a}{1 - S_{22} \Gamma_a}.$$
 (1)

By connecting three known different terminators Γ_a , Γ_b and Γ_c at port 2, (1) becomes

$$S_{11}^{(a)} = S_{11} + \frac{S_{12}^2 \Gamma_a}{1 - S_{22} \Gamma_a},$$
(2)

$$S_{11}^{(b)} = S_{11} + \frac{S_{12}^2 \Gamma_b}{1 - S_{22} \Gamma_b},$$
(3)

$$S_{11}^{(c)} = S_{11} + \frac{S_{12}^2 \Gamma_c}{1 - S_{22} \Gamma_c}.$$
 (4)

By equating S_{12}^2 at the right hand side in (2) to (4), one can obtain two linear equations of S_{11} and S_{22} as

$$\left(\frac{1}{\Gamma_{a}} - \frac{1}{\Gamma_{b}}\right) S_{11} + \left(S_{11}^{(a)} - S_{11}^{(b)}\right) S_{22} = \frac{S_{11}^{(a)}}{\Gamma_{a}} - \frac{S_{11}^{(b)}}{\Gamma_{b}},$$
(5)

$$\left(\frac{1}{\Gamma_a} - \frac{1}{\Gamma_c}\right) S_{11} + \left(S_{11}^{(a)} - S_{11}^{(c)}\right) S_{22} = \frac{S_{11}^{(a)}}{\Gamma_a} - \frac{S_{11}^{(c)}}{\Gamma_c}.$$
 (6)

From (5) and (6), S_{11} and S_{22} can be solved. In addition, S_{12}^2 can be calculated by substituting the resulted S_{11} and S_{22} into (2) to (4). Note that the sign of S_{12} is ambiguous.

B. Reflective three-antenna method

In the following derivation, each antenna is represented as a two-port network, denoted by its terminating port and radiation port as shown in Fig.1. This two-port scattering matrix describes the antenna input impedance, structural scattering and transmitting and receiving characteristics as illustrated in [7]. Taking antenna i in Fig. 1 for example, it is given as

$$\begin{bmatrix} b_1^i \\ b_2^i \end{bmatrix} = \begin{bmatrix} S_{11}^i & S_{12}^i \\ S_{21}^i & S_{22}^i \end{bmatrix} \begin{bmatrix} a_1^i \\ a_2^i \end{bmatrix}.$$
(7)

 S_{ii} is its input impedance, $S_{12}^i = S_{21}^i$ accounts for the antenna transmitting or receiving characteristics, and S_{22}^i describes the antenna structural scattering characteristics. Based on the formulation given in Sec. II.A, the scattering matrix $[S^T]$ can be calculated from three reflection measurements by terminating port *j* with three different terminators. $[S^T]$ is a cascade of three scattering matrices to account for the transmitting antenna *i*, free space propagation and the receiving antenna *j*, and it is given as

$$S_{11}^{T} = S_{11}^{i} + \frac{(S_{12}^{i})^{2} S_{22}^{j} T^{2}}{1 - S_{22}^{i} S_{22}^{j} T^{2}},$$
(8)

$$S_{22}^{T} = S_{11}^{j} + \frac{(S_{12}^{j})^{2} S_{22}^{j} T^{2}}{1 - S_{22}^{j} S_{22}^{j} T^{2}},$$
(9)

$$S_{12}^{T} = \frac{S_{12}^{I}S_{12}^{I}T}{1 - S_{22}^{I}S_{22}^{J}T^{2}},$$
(10)

where T is the range term.

As the input impedance of each antennas is measured in advance, one can calculate

 ΔS_{11} and ΔS_{22} as $\Delta S_{11} = S_{11}^T - S_{11}^i$ and $\Delta S_{22} = S_{22}^T - S_{11}^j$. The product of transmit-

ting characteristics and structural scattering of *i* and *j* antennas are then given as

$$S_{22}^{i}S_{22}^{j} = \frac{\Delta S_{11}\Delta S_{22}}{(S_{12}^{T})^{2}T^{2}},$$
(11)

$$S_{12}^{i}S_{12}^{j} = S_{12}^{T} \frac{(1 - S_{22}^{i}S_{22}^{j}T^{2})}{T}.$$
 (12)

Note that although S_{12}^{T} has a sign ambiguity problem given in Sec. II.A, the calculation of (11) is well determined.

By using the concept of three-antenna method, one can solve the transmitting characteristics of each antenna from the measured response of three pairs of three different antennas. As S_{12}^i is solved, the maximum available antenna gain G_i^m and the transducer antenna gain G_i^i of the antenna *i* can be calculated as

$$G_{i}^{m} = \frac{\sqrt{4\pi}}{\lambda} \frac{\left|S_{12}^{i}\right|^{2}}{1 - \left|S_{11}^{i}\right|^{2}} \text{ and } G_{i}^{l} = \frac{\sqrt{4\pi}}{\lambda} \left|S_{12}^{l}\right|^{2}.$$
 (13)

Since only the absolute value of S_{12}^i is involved in the calculation of antenna gain, its sign ambiguity is not important. The structural scattering characteristics of antenna i is then given as

$$S_{22}^{i} = \Delta S_{22} \frac{1 - S_{22}^{i} S_{22}^{j} T^{2}}{(S_{12}^{i})^{2} T^{2}}.$$
 (14)

Note there is no sign ambiguity problem in (14).

III. CONCLUSION

In this paper, we proposed a novel method to measure the antenna gain and struc-

tural scattering characteristics using a reflective three-antenna method. This method can eliminate the needs of a return cable, reference antenna or the polarimetric calibra-

- tion procedure.
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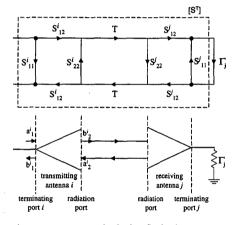


Fig. 1 Scattering parameter representaion for the reflective three-antenna method.